

1. Scope

This specification is applied to Multilayer Ceramic Chip Capacitor (MLCC) for use in electric equipment for the voltage is ranging from 100V to 630V.

The MLCC support for Lead-Free wave and reflow soldering, and electrical characteristic and reliability are same as before. (This product is compliant with the RoHS.)

2. Parts Number Code

| | С | 1206 | X | 102 | К | 101 | Т | |
|--------------|--------------|-----------|------------------|-------|-----------|--------------|----------|---------------------|
| | (1) | (2) | (3) | (4) | (5) | (6) | (7) | |
| (1)Product | | | | | (5)Capaci | tance Tolera | nce | |
| Product Code | Э | | | | Code | Tolerance | | Nominal Capacitance |
| С | Multilayer | Ceramic | Chip Capa | citor | В | ± 0.10 pF | | Less Than 10 pF |
| (2)Chin Sizo | | | | | С | ± 0.25 pF | | (Include 10 pF) |
| (2)Chip Size | | | <i>(</i> , , ,) | | D | ± 0.50 pF | | |
| Code | Length×Width | | mm(inch) | | E | ± 1.00 pF | | |
| 0201 | 0.60× 0 | .30 (.024 | 4× .011) | | F | ± 1.00 % | | More Than 10 pF |
| 0402 | 1.00× 0 | .50 (.039 | 9× .020) | | G | ± 2.00 % | | · |
| 0603 | 1.60× 0 | .80 (.063 | 3× .031) | | J | ± 5.00 % | <u> </u> | |
| 0805 | 2.00× 1 | .25 (.079 | 9× .049) | | K | ± 10.0 % | | |
| 1206 | 3.20× 1 | .60 (.126 | 6× .063) | | М | ± 20.0 % | | |
| 1210 | 3.20× 2 | .50 (.126 | 6× .098) | | Z | +80/-20 % | | |
| 1808 | 4.60× 2 | .00 (.18′ | 1× .079) | | | | | |
| 1812 | 4.60× 3 | .20 (.18′ | 1× .125) | | | | | |
| 1825 | 4.60× 6 | .35 (.18 | 1× .250) | | | | | |
| 2208 | 5.70× 2 | .00 (.220 | 0x .197) | | (6)Rated | Voltage | | |
| 2211 | 5.70× 2 | .80 (.220 | 0x .110) | | Code | F | Rated Vo | ltage (Vdc) |
| 2220 | 5.70× 5 | .00 (.220 | 0x .197) | | 101 | | 10 | |
| 2225 | 5.70× 6 | .35 (.220 | 0x .250) | | 201 | | 20 | 0 |
| | | , | | | 251 | | 25 | 0 |

(3) Temperature Characteristics

| Code | Temperature | Temperature | Temperature |
|------|----------------|-----------------------|-------------------|
| | Characteristic | Range | Coefficient |
| Ν | NPO | -55° ℃ ~+125°℃ | 30 ppm/° C |
| L | SL | -25°∁~+85° ∁ | +350~-1000ppm |
| Х | X7R | -55°∁~+125° ∁ | ± 15% |
| В | X5R | -55°C ~+85° C | ± 15% |
| S | X6S | -55° ℃ ~+105°℃ | ± 22% |
| Y | Y5V | -30°C ~+85 °C | +22/-82% |
| Z | Z5U | +10℃~+85℃ | +22/-56% |
| E | Y5U | -30°∁ ~+85 °∁ | +22/-56% |
| | | | |

| (4)Capacitance | unit :pico farads(pF) |
|----------------|--------------------------|
| Code | Nominal Capacitance (pF) |
| 5R0 | 5.0 |
| 120 | 12.0 |
| 151 | 150.0 |
| 102 | 1,000.0 |
| 103 | 10,000.0 |
| 474 | 470,000.0 |
| 105 | 1,000,000.0 |
| 106 | 10,000,000.0 |

※. If there is a decimal point, it shall be expressed by an English capital letter R

(7)Tapping

501

631

| Code | Туре |
|------|-------------|
| Т | Tape & Reel |
| В | Bulk |

500 630



3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

| Class | Characteristic | Tolera | ance | Nominal Capacitance |
|------------|----------------|-----------------|---------------|-------------------------------|
| Ι | NPO / SL | Less Then 10 pF | B (± 0.10 pF) | 0.5,1,1.5,2,2.5,3 |
| | | | C (± 0.25 pF) | 0.5,1,1.5,2,2.5,3,3.5,4,4.5,5 |
| | | | D (± 0.50 pF) | 5,6,7,8,9,10 |
| | | | E (± 1.00 pF) | 6,7,8,9,10 |
| | | More Than 10 pF | F (±1.00 %) | E-12, E-24 series |
| | | | G (±2.00 %) | |
| | | | J (± 5.00 %) | |
| | | | K (± 10.0 %) | |
| П | X7R/X5R/X7E | K (± 10.0 %), | M (± 20.0 %) | E-3, E-6 series |
| | Y5V | M (± 20.0 %), | Z(+80/-20 %) | E- 3 series |
| | Z5U | | | |
| | Y5U | | | |
| | | | | |
| 3.2 E seri | es(standard Nu | mber) | | |

3.2 E series(standard Number)

| Standard No. | | Application Capacitance | | | | | | | | | | |
|--------------|-----|-------------------------|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|
| E- 3 | 1.0 | | | 2.2 | | | | 4.7 | | | | |
| E- 6 | 1 | .0 | 1 | .5 | 2. | .2 | 3 | .3 | 4. | .7 | 6 | .8 |
| E-12 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| E-24 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| | 1.1 | 1.3 | 1.6 | 2.0 | 2.4 | 3.0 | 3.6 | 4.3 | 5.1 | 6.2 | 7.5 | 9.1 |

4. Operation Temperature Range

| Class | Characteristic | Temperature Range | Reference Temp. |
|-------|----------------|--------------------------------|-----------------|
| Ι | NPO | -55° C ~ +125°C | 25 ℃ |
| | SL | -55°C ~ +125°C | 25 ℃ |
| П | X7R | -55° C ~ +125° C | 25 ℃ |
| | X5R | -55℃ ~ +85℃ | 25 ℃ |
| | X6S | -55°C ~ +105°C | 25 ℃ |
| | Y5V | -30° C ~ +85 °C | 25 ℃ |
| | Z5U | +10℃ ~ +85℃ | 25 ℃ |
| | Y5U | -30°C ~ +85° C | 25 ℃ |
| | Other | -25 °C ~ +85°C | 25 ℃ |
| | Outer | 200 1000 | 250 |

5. Storage Condition

Storage Temperature : 5 to 40° C

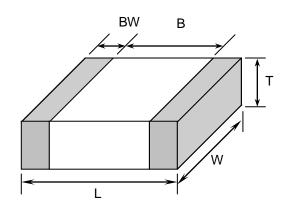
Relative Humidity : 20 to 70 %

Storage Time: 12 months max.

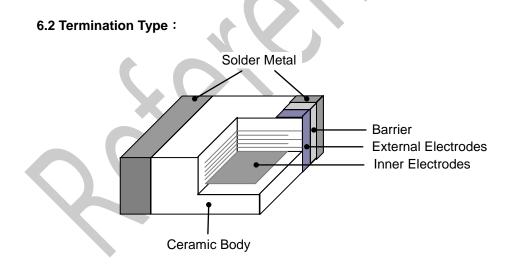


6. Dimensions

6.1 Configuration and Dimension :



| | | | | | Unit:mm |
|------|-----------------|------------|---------|---------|----------|
| TYPE | L | W | T (max) | B (min) | BW (min) |
| 0201 | 0.60 ± 0.03 | 0.30± 0.03 | 0.33 | 0.20 | 0.10 |
| 0402 | 1.00± 0.05 | 0.50± 0.05 | 0.55 | 0.30 | 0.15 |
| 0603 | 1.60± 0.10 | 0.80± 0.10 | 1.00 | 0.40 | 0.15 |
| 0805 | 2.00± 0.20 | 1.25± 0.20 | 1.45 | 0.70 | 0.20 |
| 1206 | 3.20± 0.30 | 1.60± 0.20 | 1.80 | 1.50 | 0.30 |
| 1210 | 3.20± 0.30 | 2.50± 0.20 | 2.60 | 1.60 | 0.30 |
| 1808 | 4.60± 0.30 | 2.00± 0.20 | 2.20 | 2.50 | 0.30 |
| 1812 | 4.60± 0.30 | 3.20± 0.30 | 3.00 | 2.50 | 0.30 |
| 1825 | 4.60± 0.30 | 6.35± 0.40 | 2.60 | 2.50 | 0.30 |
| 2208 | 5.70± 0.40 | 2.00± 0.20 | 2.20 | 3.50 | 0.30 |
| 2211 | 5.70± 0.40 | 2.80± 0.40 | 3.00 | 3.50 | 0.30 |
| 2220 | 5.70± 0.40 | 5.00± 0.40 | 3.00 | 3.50 | 0.30 |
| 2225 | 5.70± 0.40 | 6.35± 0.40 | 3.00 | 3.50 | 0.30 |





7. Performance

| No. | ltem | | S | specification | Test Condition | | |
|-----|---|-------------------------------------|--|---|--|--|--|
| 1 | Visua | ıl | No abnormal exterior appearance | | Visual inspection | | |
| 2 | Dimens | ion | See Page 3 | | Visual inspection | | |
| 3 | Insulati Resista | on | 10,000MΩ or 500/CΩ Product Whichever Is Smaller | | V \leq 500V, Rated Voltage V $>$ 500V, Applied 500Vdc Charge Time : 60sec. Is applied less than 50mA current. | | |
| 4 | Capacitance | Class I NPO/SL Class II | Within The Specified Tolerance Within The Specified Tolerance | | $\begin{tabular}{lllllllllllllllllllllllllllllllllll$ | | |
| 5 | Q Tanð | Class I NPO/SL Class II | More Than 30 30pF & Below (C : Capacita Char. X7R Z5U/Y5U | $Q \ge 400 + 20C$ | Class II :FrequencyVoltageX7R1KHz±10% 1.0 ± 0.2 VrmsZ5U/Y5U1KHz±10% 1.0 ± 0.2 VrmsPerform a heat temperature at 150±5°C for 30min. then place room temp. for 24±2hr. | | |
| 6 | Withstan Voltag | • | No dielectric mechanical b | breakdown or breakdown | 200% /150%/120%/100% Rated Voltage For information which product has which applied voltage, please contact with HEC sales representative. Voltage ramp up rate ≦ 500v/sec for 1~5 sec. charge/discharge Current is less than 50mA. | | |
| 7 | Temperature Capacitance Coefficient | Class I Class II | Char. Temp. F NPO -55°℃~+1 -30°℃~+1 SL -30°℃~+1 -30°℃~+1 Y5U -30°℃~+10°℃~ Z5U +10°℃~ | +125℃ ± 30 ppm/℃ 85℃ +350~-1000ppm Range Cap. Change(%) +125℃ ± 15% +85℃ +22% ~-56% |) Class I : [C2-C1/C1(T2-T1)] × 100% Class II : | | |
| 8 | Adhesive S of Termin | | | of peeling shall occur on | | | |
| 9 | | Appear- ance C-Meter | No mechanica Capacitance C Char. NPO SL X7R Y5U/Z5U | | Bending shall be applied to the 1.0 mm with 1.0 mm/sec. R230 Bending Limit 45±1mm Bending | | |



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Reference sheet

| No. | lte | em | Specific | cation | Test Condition | | |
|-----|---------------------------------------|---|---|---|---|--|--|
| 10 | Solderability | | More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve . | | Solder Temperature : $245 \pm 5^{\circ}$ C Dip Time : 5 ± 0.5 sec. Immersing Speed : $25 \pm 10\%$ mm/s Solder : Lead Free Solder Flux :Rosin Preheat : At 80~120 °C for 10~30sec | | |
| 11 | Resistance To Soldering Heat | ance Capacit- ance Q Class Ι Tan δ Class ΙΙ Insulation Resistance Withstand Voltage | No mechanical dam Characteristic Class I (NPO/SL) Class X7R II Z5U/Y5U To satisfy the specifi To satisfy the specifi To satisfy the specifi | Cap. Change Within \pm 2.5% or \pm 0.25pFwhichev er is larger of initial value Within \pm 10% Within \pm 20% ied initial value ied initial value ied initial value | Class II capacitor shall be set for 48 ± 4 hours at room temperature after one hour heat treatment at $150 \pm 0/-10^{\circ}$ C before initial measure. Preheat : At $150\pm10^{\circ}$ C For $60\sim120$ sec. Dip : Solder Temperature of $260\pm5^{\circ}$ C Dip Time : 10 ± 1 sec. Immersing Speed : $25\pm10\%$ mm/s Flux :Rosin Measure at room temperature after cooling for Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours | | |
| 12 | Tempera ture Cycle | Appear- ance Capacit- ance Q Class I Tan ō Class II Insulation Resistance | No mechanical dam Characteristic Class I (NPO/SL) Class X7R II Z5U/Y5U To satisfy the specifi To satisfy the specifi | Cap. Change Within ± 2.5% or ±0.25pFwhichev er is larger of initial value Within ± 7.5% Within ± 20% ied initial value | Class II capacitor shall be set for 48 ± 4 hours at room temperature after one hour heat treatment at 150 +0/-10 °C before initial measure. Capacitor shall be subjected to five cycles of the temperature cycle as following: $\boxed{\frac{\text{Step} \text{Temp.(°C}) \text{Time(min)}}{1 \text{Min Rated Temp. +0/-3} 30}}$ $\boxed{\frac{2}{4} 25 3}$ $\boxed{\frac{3}{4} 25 3}$ Measure at room temperature after cooling for Class I :24 ± 2 Hrs Class II :48 ± 4 Hrs Solder the capacitor on P.C. board shown in Fig 2. before testing. | | |
| 13 | Humidity | Appear- ance Capacit- ance Q Class Ι Tan δ Class Ι I Insulation | (NPO/SL) 4 ii V Class X7R V | Cap. ChangeWithin $\pm 5.0\%$ or $\pm 0.5pF$ whichever s larger of initialvalueWithin $\pm 15\%$ Within $\pm 30\%$ $a \ge 350$ $275 + 2.5 \times C$ Maximum 5.0% 5.0% | Class II capacitor shall be set for 48± 4 hours at room temperature after one hour heat treatment at 150+0/-10 °C before initial measure. Temperature : 40± 2°C Relative Humidity : 90 ~ 95%RH Test Time : 500 +12/-0Hr Measure at room temperature after cooling for Class I : 24 ± 2Hrs Class II : 48 ± 4Hrs Solder the capacitor on P.C. board shown in Fig 2. before testing. | | |



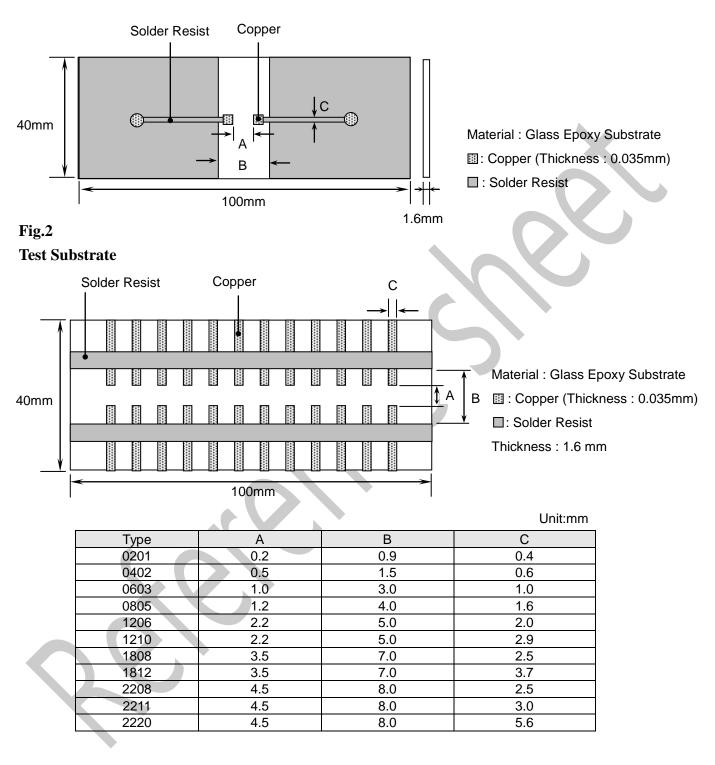
MULTILAYER CERAMIC CHIP CAPACITORS

| | R | esistance | smaller. | | | | |
|-----|---------------------|-----------------|--------------------|----------------------|---|--|--|
| No. | Iten | n | Specification | | Test Condition | | |
| 14 | High Temperature | Appear- ance | • | | Class II capacitors applied DC voltage (following table) is applied for one hour at maximum | | |
| | Load | Capacit- | Characteristic | Cap. Change | operation temperature $\pm 3^{\circ}$ C then shall be set for | | |
| | (Life Test) | ance | Class I | | 48±4 hours at room temperature and the initial | | |
| | | | (NPO/SL) | | measurement shall be conducted. | | |
| | | | | r is larger | Applied Voltage : | | |
| | | | Class X7R | Within ± 15% | | | |
| | | | II Z5U/Y5L | | Applied Voltage | | |
| | | Q | More Than 30pF | | 150%Rated Voltage | | |
| | | Class I | | \geq 275 + 2.5× C | 120% Poted Veltage | | |
| | | Tan δ | Char. | maximum | 120%Rated Voltage | | |
| | | Class ∏ | X7R | 5.0% | 100%Rated Voltage | | |
| | | | Z5U/Y5U | 5.0% | For information which product has which applied | | |
| | | | 1,000MΩ or 50/C | | | | |
| | | Resistance | smaller. | (C in Farad) | voltage,please contact with HEC sales representative. | | |
| | | | | | | | |
| | | | | | | | |
| | | | | | Temperature : max. operation temperature | | |
| | | | | | Test Time : 1000 +12/-0Hr | | |
| | | | | | Current Applied : 50 mA Max. Measure at room temperature after cooling for | | |
| | | | | | Class I : 24 ± 2 Hours | | |
| | | | | | Class II : 48 \pm 4 Hours | | |
| | Vibration | Appear- | No mochanical dr | amage shall occur | Solder the capacitor on P.C. Board shown in | | |
| 15 | VIDIATION | ance | NO MECHANICALUA | amage shall occur | Fig 2. before testing. | | |
| | | Capacit- | Characteristic | Cap. Change | | | |
| | | ance | Class I | Within ± 2.5% or | Vibrate the capacitor with amplitude of 1.5mm | | |
| | | | (NPO/SL) | ±0.25pFwhichev | P-P changing the frequencies from 10Hz to | | |
| | | | (111 0/02) | er is larger | 55Hz and back to 10Hz in about 1 min. | | |
| | | | Class X7R | Within ± 7.5% | | | |
| | | | I Z5U/Y5L | | Repeat this for 2 hours each in 3perpendicular | | |
| | | Q | | cified initial value | directions. | | |
| | | Class I | | | | | |
| | | Tan δ | To satisfy the spe | cified initial value | 1 | | |
| | | Class ∏ | | | | | |
| | | Insulation | To satisfy the spe | cified initial value | 1 | | |
| | | Resistance | | | | | |
| L | I | _ 100.0101100 | | | | | |



Fig.1

P.C. Board for Bending Strength Test



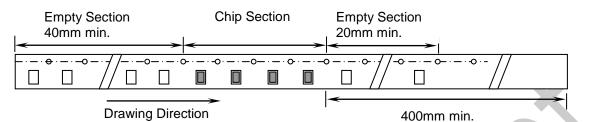


8. Packing

8.1 Bulk Packing

According to customer request.

8.2 Chip Capacitors Tape Packing



8.3 Material And Quantity

| Таре | 0201 | 0402 | 0603/ | /0805 |
|----------|-----------------|-----------------|----------------|----------------|
| Material | T≦0.33mm | T≦0.55mm | T≦0.90mm | T>0.90mm |
| Paper | 15,000 pcs/Reel | 10,000 pcs/Reel | 4,000 pcs/Reel | NA |
| Plastic | NA | NA | NA | 3,000 pcs/Reel |
| | | | | |

| Таре | | 1206 | |
|----------|----------------|--------------------------------|----------------|
| Material | T≦0.90mm | 0.90 mm $<$ T \leq 1.25 mm | T>1.25mm |
| Paper | 4,000 pcs/Reel | NA | NA |
| Plastic | NA | 3,000 pcs/Reel | 2,000 pcs/Reel |

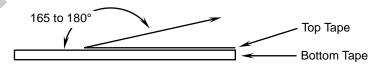
| Таре | | 1808/1210 | |
|----------|---------------|--|--------------------|
| Material | T≦1.25mm | 1.25mm <t≦2.40mm< td=""><td>T>2.40mm</td></t≦2.40mm<> | T>2.40mm |
| Paper | NA | NA | NA |
| Plastic | 3000 pcs/Reel | 2000 pcs/Reel | 500/1,000 pcs/Reel |

| Таре | 1812/22 | 11/2220 | 1825 | /2225 | 2208 |
|----------|---------------|--------------|--------------|--------------|---------------|
| Material | T≦2.20mm | T>2.20mm | T≦2.20mm | T>2.20mm | T≦2.20mm |
| Paper | NA | NA | NA | NA | NA |
| Plastic | 1000 pcs/Reel | 700 pcs/Reel | 700 pcs/Reel | 400 pcs/Reel | 1000 pcs/Reel |
| | | | | | |

NA: Not Available

8.4 Cover Tape Reel Off Force

- 8.4.1 Peel-Off Force
 - 5 g·f \leq Peel-Off Force \leq 70 g·f
- 8.4.2 Measure Method

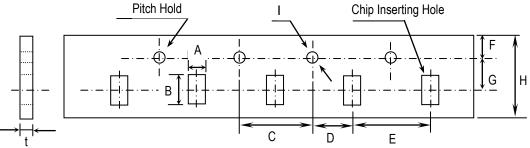




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Reference sheet

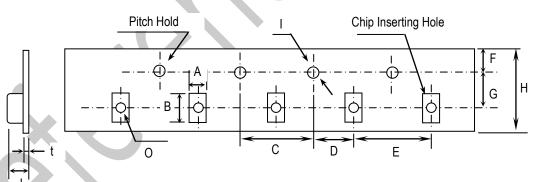
8.5 Paper Tape



| | | | | | Unit:mm |
|------|-----------|-----------|-----------|------------|-----------|
| TYPE | A | В | С | D | E |
| 0201 | 0.37± 0.1 | 0.67± 0.1 | 4.00± 0.1 | 2.00± 0.05 | 2.00± 0.1 |
| 0402 | 0.61± 0.1 | 1.20± 0.1 | | | |
| 0603 | 1.10± 0.2 | 1.90± 0.2 | | | 4.00± 0.1 |
| 0805 | 1.50± 0.2 | 2.30± 0.2 | | | |
| 1206 | 1.90± 0.2 | 3.50± 0.2 | | | |
| 1210 | 2.90± 0.2 | 3.60± 0.2 | | | |

| TYPE | F | G | Н | I | t |
|------|------------|------------|-----------|-----------------|-----------|
| 0201 | 1.75± 0.10 | 3.50± 0.05 | 8.0± 0.30 | φ 1.50 +0.10/-0 | 1.10 max. |
| 0402 | | | | | |
| 0603 | | | | | |
| 0805 | | | | | |
| 1206 | | | | | |
| 1210 | | | | | |

8.6 Plastic Tape



Unit:mm

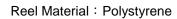
| Туре | A | В | С | D | E | F |
|------|---------|---------|----------|-----------|----------|-----------|
| 0805 | 1.5±0.2 | 2.3±0.2 | 4.0± 0.1 | 2.0± 0.05 | 4.0± 0.1 | 1.75± 0.1 |
| 1206 | 1.9±0.2 | 3.5±0.2 | | | | |
| 1210 | 2.9±0.2 | 3.6±0.2 | | | | |
| 1808 | 2.5±0.2 | 4.9±0.2 | | | | |
| 1812 | 3.6±0.2 | 4.9±0.2 | | | 8.0± 0.1 | |
| 1825 | 6.9±0.2 | 4.9±0.2 | | | | |
| 2208 | 2.5±0.2 | 6.1±0.2 | | | | |
| 2211 | 3.2±0.2 | 6.1±0.2 | | | | |
| 2220 | 5.4±0.2 | 6.1±0.2 | | | | |
| 2225 | 6.9±0.2 | 6.1±0.2 | | | | |

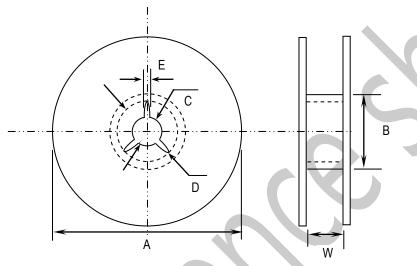


MULTILAYER CERAMIC CHIP CAPACITORS

| Туре | G | Н | | J | t | 0 |
|------|-----------|------------|--------------|----------|----------|----------|
| 0805 | 3.5± 0.05 | 8.0± 0.3 | φ 1.5+0.1/-0 | 3.0 max. | 0.3 max. | 1.0± 0.1 |
| 1206 | | | | | | |
| 1210 | | | | | | |
| 1808 | 5.5± 0.05 | 12.0 ± 0.3 | | 4.0 max. | | 1.5± 0.1 |
| 1812 | | | | | | |
| 1825 | | | | | | |
| 2208 | | | | | | |
| 2211 | | | | | | |
| 2220 | | | | | | |
| 2225 | | | | | | |

8.7 Reel Dimensions





Unit:mm

| Туре | А | В | С | D | E | W |
|------|-----------|----------|-----------|-----------|---------|----------|
| 0201 | φ 382 max | φ 50 min | φ 13± 0.5 | φ 21± 0.8 | 2.0±0.5 | 10± 0.15 |
| 0402 | | | | | | |
| 0603 | | | | | | |
| 0805 | | | | | | |
| 1206 | | | | | | |
| 1210 | | | | | | |
| 1808 | φ 178±0.2 | φ 60±0.2 | | | | 13±0.3 |
| 1812 | | | | | | |
| 1825 | | | | | | |
| 2208 | | | | | | |
| 2211 | | | | | | |
| 2220 | | | | | | |
| 2225 | | | | | | |



Precautionary Notes:

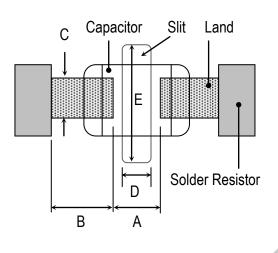
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40°C and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

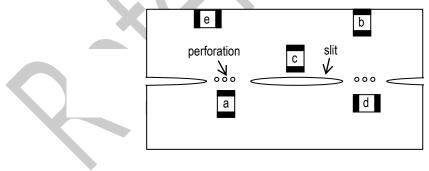
2.1 Size and recommend land dimensions for reflow soldering .



| EIA Code | Chip | (mm) | | L | and (mm) | | |
|----------|------|------|---------|---------|----------|---------|---------|
| EIA Code | L | W | А | В | С | D | Е |
| 0201 | 0.60 | 0.30 | 0.2~0.3 | 0.2~0.4 | 0.2~0.4 | | |
| 0402 | 1.00 | 0.50 | 0.3~0.5 | 0.3~0.5 | 0.4~0.6 | | |
| 0603 | 1.60 | 0.80 | 0.4~0.6 | 0.6~0.7 | 0.6~0.8 | | |
| 0805 | 2.00 | 1.25 | 0.7~0.9 | 0.6~0.8 | 0.8~1.1 | | |
| 1206 | 3.20 | 1.60 | 2.2~2.4 | 0.8~0.9 | 1.0~1.4 | 1.0~2.0 | 3.2~3.7 |
| 1210 | 3.20 | 2.50 | 2.2~2.4 | 1.0~1.2 | 1.8~2.3 | 1.0~2.0 | 4.1~4.6 |
| 1808 | 4.60 | 2.00 | 2.8~3.4 | 1.8~2.0 | 1.5~1.8 | 1.0~2.8 | 3.6~4.1 |
| 1812 | 4.60 | 3.20 | 2.8~3.4 | 1.8~2.0 | 2.3~3.0 | 1.0~2.8 | 4.8~5.3 |
| 1825 | 4.60 | 6.35 | 2.8~3.4 | 1.8~2.0 | 5.1~5.8 | 1.0~4.0 | 7.1~8.3 |
| 2208 | 5.70 | 2.00 | 4.0~4.6 | 2.0~2.2 | 1.5~1.8 | 1.0~4.0 | 3.6~4.1 |
| 2211 | 5.70 | 2.80 | 4.0~4.6 | 2.0~2.2 | 2.0~2.6 | 1.0~4.0 | 4.4~4.9 |
| 2220 | 5.70 | 5.00 | 4.0~4.6 | 2.0~2.2 | 3.5~4.8 | 1.0~4.0 | 6.6~7.1 |
| 2225 | 5.70 | 6.35 | 4.0~4.6 | 2.0~2.2 | 5.1~5.8 | 1.0~4.0 | 7.1~8.3 |
| | | • | - | | - | | |

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board. Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended. Susceptibility to stress is in the order of: a>b>c and d>e



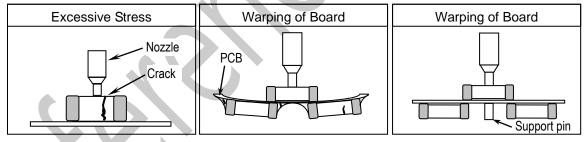


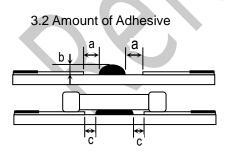
2.3 Layout Recommendation

| Example | Use of Common Solder Land | Solder With Chassis | Use of Common Solder Land With Other SMD |
|----------------|---|--|---|
| Need to Avoid | Lead Wire Chip Solder Adhesive PCB Solder Land | Chassis \downarrow Excessive Solder \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow | Solder Land |
| Recommendation | Lead Wire Chip Solder Resist | Solder Resist β $\alpha > \beta$ | |

3. Mounting

3.1 Sometimes crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.





| Example | : | 0805 | & | 1206 |
|---------|---|------|---|------|
|---------|---|------|---|------|

| a | 0.2mm min. |
|---|------------------------------|
| b | 70 ~ 100 μm |
| С | Do not touch the solder land |

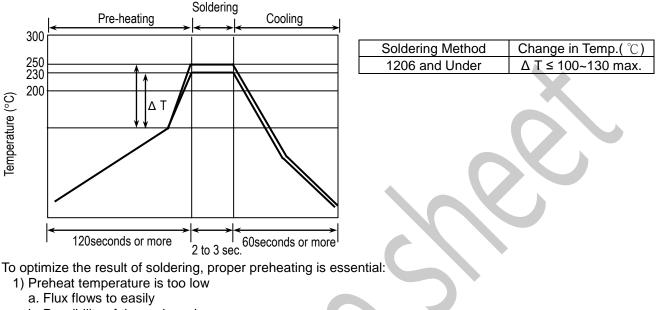


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at 230 to 250°C. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



- b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

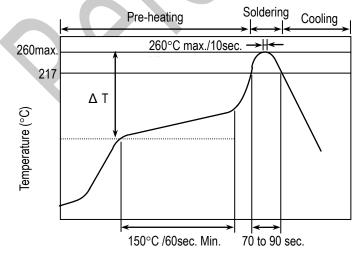
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100°C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed 3°C/Sec.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



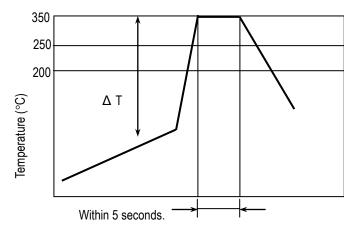
% The cycles of soldering : Twice (max.)

| Soldering Method | Change in Temp.($^{\circ}$ C) |
|------------------|------------------------------------|
| 1206 and Under | Δ T \leq 190 °C |
| 1210 and Over | Δ T \leq 130 $^{\circ}$ C |



4.3 Hand Soldering

Sudden temperature change in components, results in a temperature gradient recommended in the following table, and therefore may cause internal thermal cracks in the components. In general a hand soldering method is not recommended unless proper preheating and handling practices have been taken. Care must also be taken not to touch the ceramic body of the capacitor with the tip of solder Iron.



| Soldering Method | Change in Temp.($^\circ \mathbb{C}$) |
|------------------|--|
| 1206 and Under | Δ T \leq 150 $^{\circ}$ C |
| 1210 and Over | Δ T \leq 130 $^{\circ}$ C |

How to Solder Repair by Solder Iron

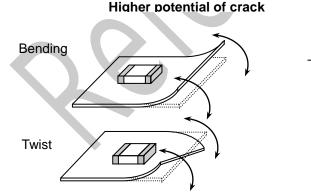
1) Selection of the soldering iron tip

The required temperature of solder iron for any type of repair depends on the type of the tip, the substrate material, and the solder land size.

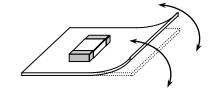
- 2) recommended solder iron condition
 - a.) Preheating Condition : Board and components should be preheated sufficiently at 150°C or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350°C., and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - f.) Do not touch the ceramic body with the tip of solder iron. Direct contact of the soldering iron tip to ceramic body may cause thermal cracks.
 - g.) After soldering operation, let the products cool down gradually in the room temperature.

5. Handling after chip mounted

5.1 Proper handling is recommended, since excessive bending and twist of the board, depends on the orientation of the chip on the board, may induce mechanical stress and cause internal crack in the capacitor.



Lower potential of crack



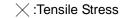
5.2 There is a potential of crack if board is warped due to excessive load by check pin



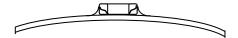


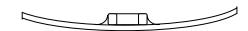
5.3 Mechanical stress due to warping and torsion.

- (a) Crack occurrence ratio will be increased by manual separation.
- (b) Crack occurrence ratio will be increased by tensile force , rather than compressive force.

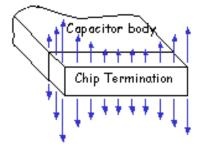


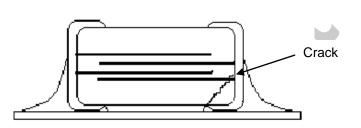
○ :Compressive Stress





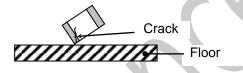
Capacitor Stress Analysis



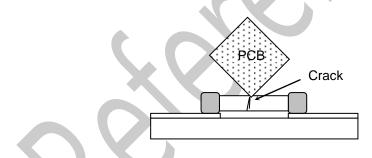


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 In piling and stacking of the P.C. boards after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor mounted on another board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep the storage temperature between +5 to +40°C and under humidity of 20 to 70% RH. The shelf life of capacitors is 12 months.